# How to Measure the Drive Level of a Quartz Crystal

June 21, 2021 by Dr. Steve Arar

Learn	why the	drive le	vel of y	our qu	uartz	crystal	oscillator	is in	<b>aporta</b> i	nt
and se	everal me	thods fo	or how t	to mea	isure i	it.				

Drive level refers to the amount of power dissipated in a crystal. A crystal has mechanical vibrations. A higher drive level can increase the amplitude of the vibrations to an unacceptable level and cause undesired effects. To limit these vibrations, the power dissipated in the crystal should not exceed the value specified by the manufacturer.

Typical drive level values are in the range of 100  $\mu$ W. With smaller surface mount crystals, the rated drive level can be even smaller (about 10  $\mu$ W).

In this article, we'll take a look at the test setups and the related equations that can be used to measure the crystal power level.

## **Drive Level Dependency**

Increasing the drive level can lead to an increase in the motional resistance and frequency of the crystal. This effect, commonly referred to as drive level dependency (DLD), is illustrated in Figure 1.

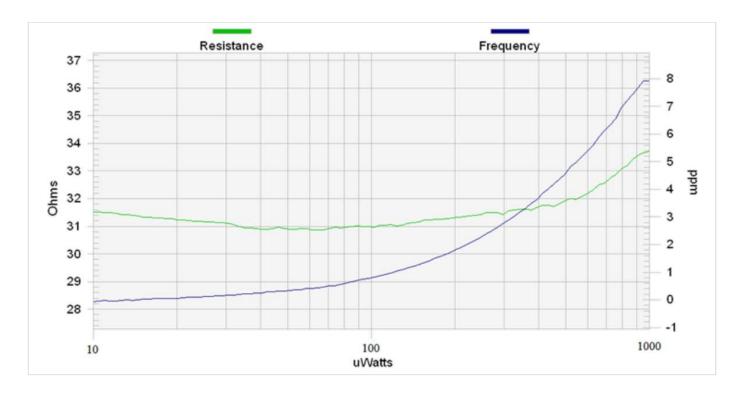


Figure 1. Crystal motional resistance and frequency versus drive level. Image courtesy of Renesas.

Very low drive levels can also increase the series resistance of a crystal to a value that makes the oscillator unable to start up. Due to this effect, a given crystal will sometimes start up successfully and fail at other times.

These crystals are sometimes referred to as "sleeping crystals". Interestingly, the crystals that have been inactive for some time can also exhibit a large series resistance well above the rated value. This can also lead to a crystal that is occasionally unable to start up. The inactivity period that can cause this effect can be hours to weeks depending on the crystal quality.

### **Overdriving Can Cause Serious Damage**

Exceeding the stated drive level can lead to several undesired effects. It can shorten the device lifetime, cause oscillation frequency fluctuations, and degrade the stability. Figure 2 shows how exceeding the maximum drive level can change the frequency versus temperature response of a crystal.

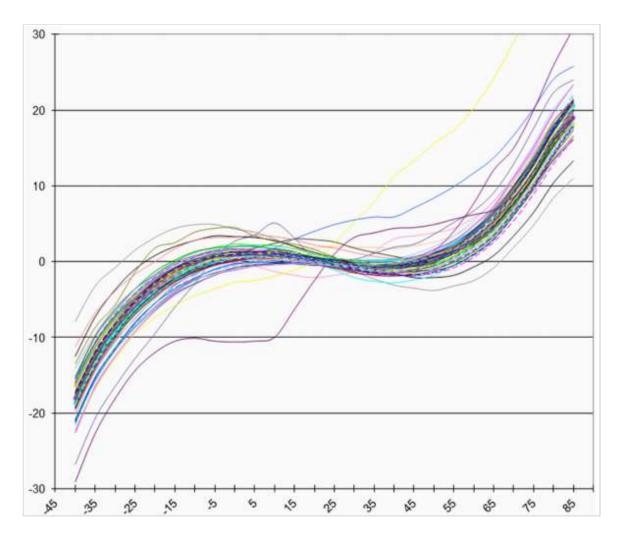


Figure 2. The effect of exceeding max drive level on a crystal's frequency and temperature response. Image courtesy of Raltron.

In this example, crystals rated at  $10 \mu W$  are overdriven at  $500 \mu W$ . Instead of having smooth frequency versus temperature curves, we observe an erratic temperature response. At significantly higher power levels (e.g., at 10x the rated value), overdriving can cause irreversible damage to the crystal.

## **Measuring Drive Level Using a Current Probe**

Since the crystal drive level cannot be measured directly, we need to measure a circuit quantity, such as a voltage or current, and use the crystal electrical model to approximate its power level. The <u>equivalent electrical circuit</u> for a crystal is shown in Figure 3.

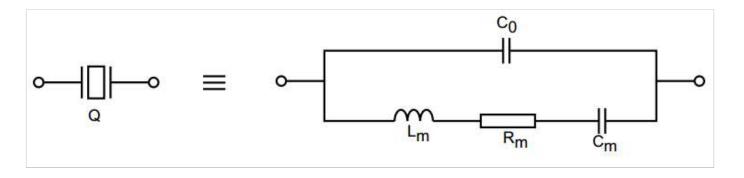


Figure 3. The equivalent electrical circuit for a crystal. Image courtesy of <u>STMicroelectronics</u>.

We only need to find the effective resistance of this network at resonance and measure the crystal current to calculate the drive level. The <u>crystal equivalent series resistance (ESR) at load capacitance  $C_L$  is given by:</u>

$$ESR = R_m igg(1 + rac{C_0}{C_L}igg)^2$$

The drive level can be obtained as:

$$DL = ESR imes I_{Q,\,RMS}^{}^{}^{2}$$

#### **Equation 1**

where  $I_{Q, RMS}$  denotes the RMS current flowing through the crystal. As shown in Figure 4, a current probe can be used to measure the crystal current.

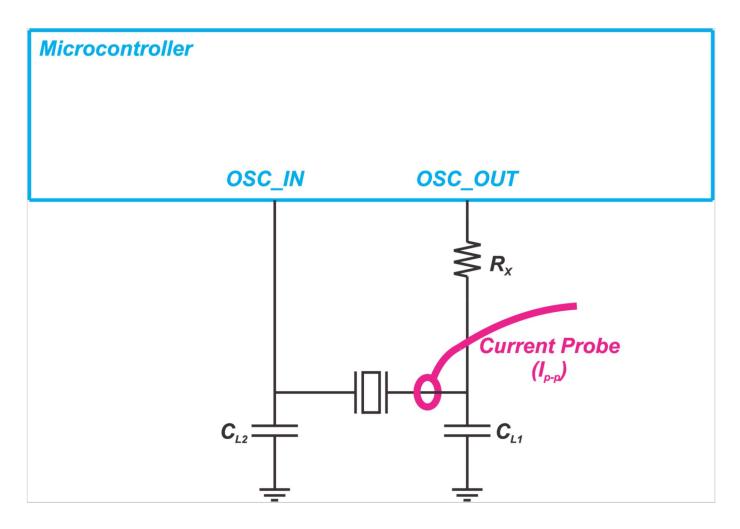


Figure 4. Using a current probe to measure crystal current

Figure 5 shows applying this technique in practice.

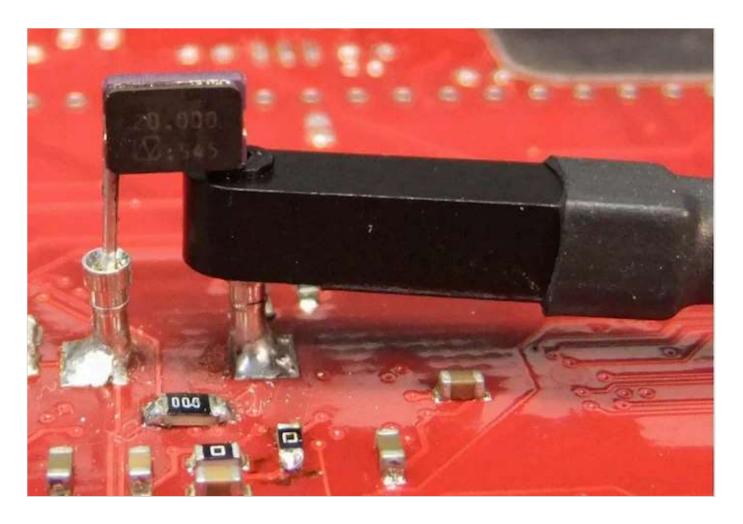


Figure 5. A PCB with a current probe measuring crystal current. Image courtesy of <u>Infineon</u>.

The crystal current is usually either sinusoidal or saw-tooth. Figure 6 shows an example where the current waveform is approximately sinusoidal.

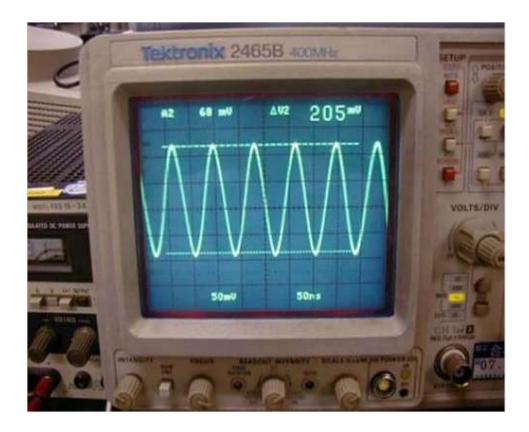


Figure 6. The current flowing through the crystal. Image courtesy of **Epson**.

With a sinusoidal waveform, we can apply the following equation to find the RMS value from the peak-to-peak value ( $I_{Q, p-p}$ ):

$$I_{Q,\,RMS}=rac{I_{Q,\,p-p}}{2\sqrt{2}}$$

With a saw-tooth waveform, the RMS value is given by:

$$I_{Q,\,RMS}=rac{I_{Q,\,p-p}}{2\sqrt{3}}$$

Scroll to continue with content

Depending on the waveform type, one of these two equations should be used to find the RMS value from the peak-to-peak value. Then, we can substitute the RMS current in Equation 1 and calculate the drive level.
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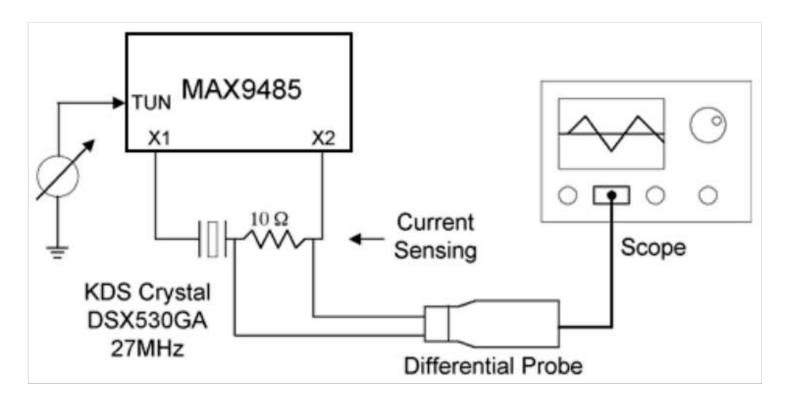


Figure 7. Representation of a setup to find the crystal current. Image courtesy of Maxim Integrated.

To make sure that the resistor is small enough and does not contribute a significant measurement error, the <u>Maxim Integrated application note</u> suggests that we increase the resistor value slightly and verify that the sensed current is barely changed. In this example, the resistor value is changed from  $10 \Omega$  to  $20 \Omega$ .

### Finding the Drive Level by Measuring the Amplifier Input Voltage

In this case, the RMS voltage at the input of the amplifier ( $V_{IN, RMS}$ ) is measured through a low-capacitance oscilloscope probe (less than 1 pF).

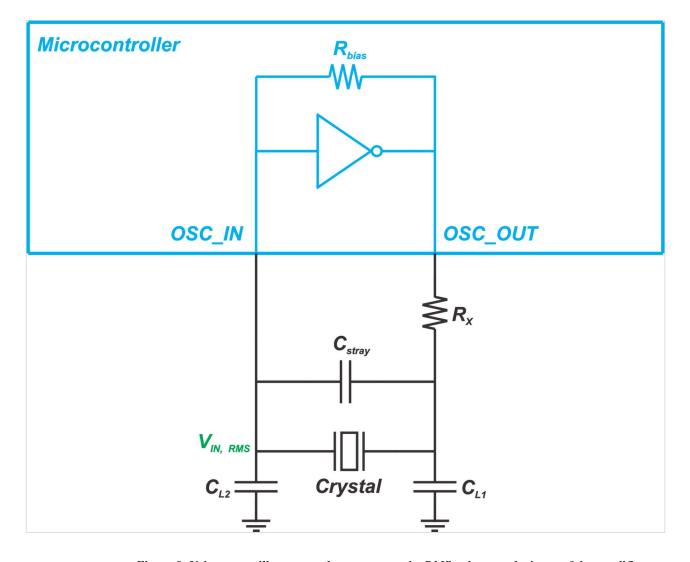


Figure 8. Using an oscilloscope probe to measure the RMS voltage at the input of the amplifier

Having  $V_{IN, RMS}$ , we can calculate the current flowing through  $C_{L2}$  as:

$$I_{RMS}=(2\pi f C_{L2})V_{IN,~RMS}$$

To be more accurate, we can also include the parasitic effects and substitute  $C_{L2}$  with  $C_{total}$  given below:

$$C_{total} = C_{L2} + rac{C_s}{2} + C_{Probe}$$

where  $C_{Stray}$  and  $C_{Probe}$  are the stray and probe capacitances, respectively. The current that flows into the amplifier input is much smaller than the current that flows through this total capacitance. Hence, we can assume that the total current flowing through the crystal is equal to the current flowing through  $C_{total}$ . This gives us the drive level as:

$$DL = ESR imes {I_{RMS}}^2 = ESR imes ig( 2\pi f C_{total} V_{IN,~RMS} ig)^2$$

Assuming that the voltage waveform at the amplifier input is sinusoidal, we can use

$$V_{IN,~RMS} = rac{V_{IN,~p-p}}{2\sqrt{2}}$$

and calculate the drive level as:

$$DL = ESR imes \left(\pi f C_{total}
ight)^2 imes rac{{V_{p-p}}^2}{2}$$

### Finding the Drive Level by Measuring the Crystal Voltage

For the sake of thoroughness, I would like to mention another equation that is sometimes used to calculate the drive level. This method is based on measuring the voltage across the crystal.

We know that, at resonance, the magnitude of the impedance of the motional branch in the crystal model (the series combination of  $L_m$ ,  $C_m$ , and  $R_m$ ) is equal to the magnitude of the impedance of the parallel combination of  $C_L$  and  $C_0$ . Hence, we can approximate the RMS current flowing through the motional arm by:

$$I_{Motional~Arm,~RMS} = V_{Crystal,~RMS} imes (2\pi f(C_L + C_0))$$

where  $V_{Crystal,\ RMS}$  denotes the measured RMS voltage across the crystal. The drive level can be found by:

$$DL = R_m imes \left(2\pi f(C_L + C_0)
ight)^2 imes V_{Crystal,\ RMS}^{}^2$$

Assuming that the crystal voltage is a sinusoidal waveform with a peak value of  $V_p$ , we can substitute  $V_{Crystal,RMS}$  with

$$\frac{v_p}{\sqrt{2}}$$

and obtain the following equation:

$$DL = 2 imes R_m imes (\pi f (C_L + C_0) V_p)^2$$

The <u>CC26xx and CC13xx family of wireless MCUs</u> from TI provide functions that return the amplitude of the crystal oscillation voltage in mV. Having the oscillation amplitude, we can easily apply the above equation and find the crystal drive level during operation. If the rated drive level is exceeded, we need to re-examine our design to avoid any crystal reliability issues.

### Adding a Series Resistor to Limit the Drive Level

If the drive level is not within the expected range, a resistor can be added to limit the current and consequently the drive level of the crystal ( $R_x$  in Figure 4). After  $R_x$  is chosen based on the target drive level, we should ensure that the frequency is within the expected accuracy.

Moreover, the oscillator negative resistance should be examined to make sure that it provides sufficient margin. A large  $R_x$  can prevent the oscillator from oscillating.

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